

STP62NS04Z

N-channel clamped 12.5mΩ - 62A - TO-220 Fully protected MESH OVERLAY™ Power MOSFET

General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D
STP62NS04Z	Clamped	<0.015Ω	62A

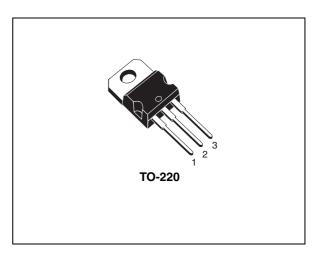
- 100% avalanche tested
- Low capacitance and gate charge
- 175°C maximum junction temperature

Description

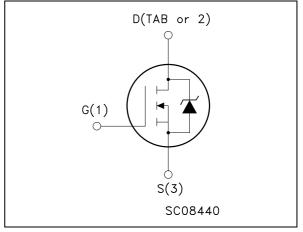
This fully clamped MOSFET is produced by using the latest advanced Company's Mesh Overlay process which is based on a novel strip layout. The inherent benefits of the new technology coupled with the extra clamping capabilities make this product particularly suitable for the harshest operation conditions such as those encountered in the automotive environment. Any other application requiring extra ruggedness is also recommended.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STP62NS04Z	P62NS04Z	TO-220	Tube

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Electrical ratings

Table 1. Absolute maximum ratings	Table 1.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	Clamped	V
V _{GS}	Gate-source voltage	Clamped	V
Ι _D	Drain current (continuous) at $T_C = 25^{\circ}C$	62	А
Ι _D	Drain current (continuous) at T _C =100°C	37.5	А
I _{DG}	Drain gate current (continuous)	± 50	
I _{GS}	Gate sourcecurrent (continuous)	± 50	
I _{DM} ⁽¹⁾	Drain current (pulsed)	248	А
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	110	W
	Derating factor	0.74	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	8	V/ns
E _{AS} ⁽³⁾	Single Pulse Avalanche Energy	500	mJ
V _{ESD}	ESD (HBM - C = 100pF, R = 1.5 kΩ)	8	V
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

1. Pulse width limited by safe operating area

2. $I_{SD} \leq 40A$, di/dt $\leq 100A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

3. Starting $T_J = 25 \text{ }^{\circ}\text{C}$, $I_D = 20\text{A}$, $V_{DD} = 20\text{V}$

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance junction-case Max	1.36	°C/W
R _{thJA}	Thermal resistance junction-ambient Max	62.5	°C/W
Т	Maximum lead temperature for soldering purpose	300	°C

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1mA, V _{GS} = 0	33			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 16V			10	μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{GS} = \pm 10V$			10	μA
V _{GSS}	Gate-Source Breakdown Voltage	I _{GS} = 100 μΑ	18			V
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 30A		12.5	15	mΩ

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V, I _D = 30A		20		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f = 1 MHz, V _{GS} = 0		1330 420 135		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 20V, I_D = 40A$ $V_{GS} = 10V$		34 10 11.5	47	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 20V, I_D = 20A, R_G =4.7 Ω , V_{GS} = 10V <i>Figure 13 on page 8</i>		13 104 41 42		ns ns ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time Fall time Cross-over time			30 54 90		ns ns ns



Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				62	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				248	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 62A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 40A,$ di/dt = 100A/µs, $V_{DD} = 20V, T_J = 150^{\circ}C$ <i>Figure 15 on page 8</i>		45 65 2.9		ns μC Α

Table 6.Source drain diode

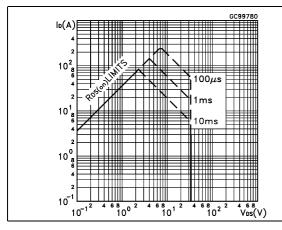
1. Pulse width limited by safe operating area

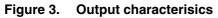
2. Pulsed: pulse duration=300µs, duty cycle 1.5%

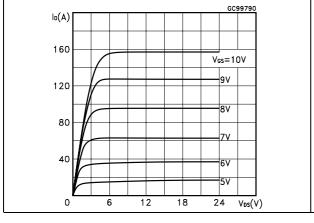


2.1 Electrical characteristics (curves)

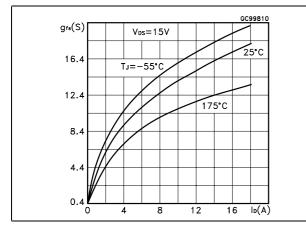
Figure 1. Safe operating area

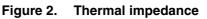












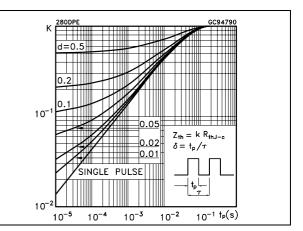


Figure 4. Transfer characteristics

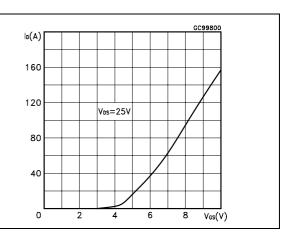
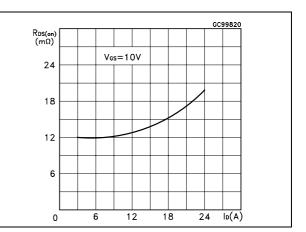


Figure 6. Static drain-source on resistance



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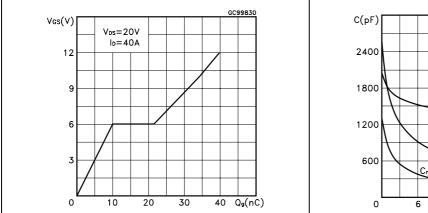
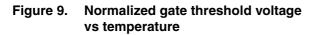


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations



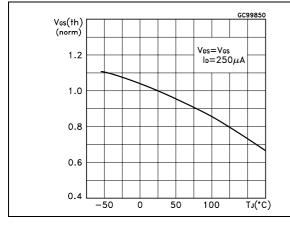


Figure 11. Source-drain diode forward characteristics

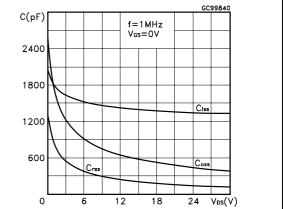


Figure 10. Normalized on resistance vs temperature

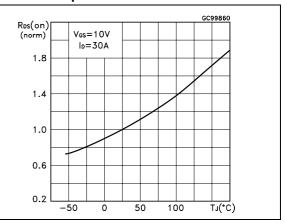
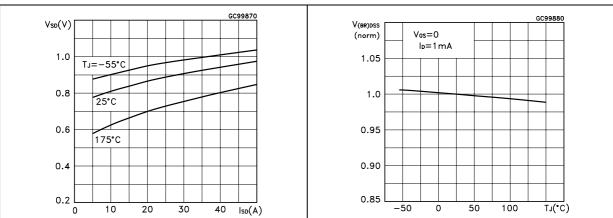


Figure 12. Normalized B_{VDSS} vs temperature



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3 Test circuit

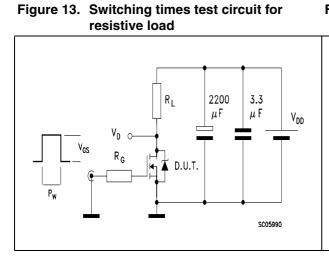
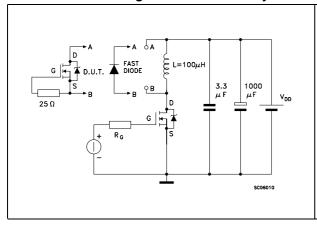


Figure 15. Test circuit for inductive load switching and diode recovery times





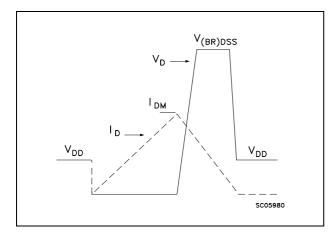
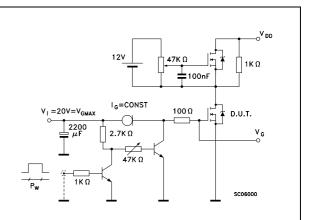
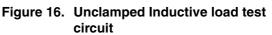
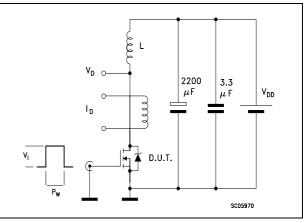


Figure 14. Gate charge test circuit







4 Package mechanical data

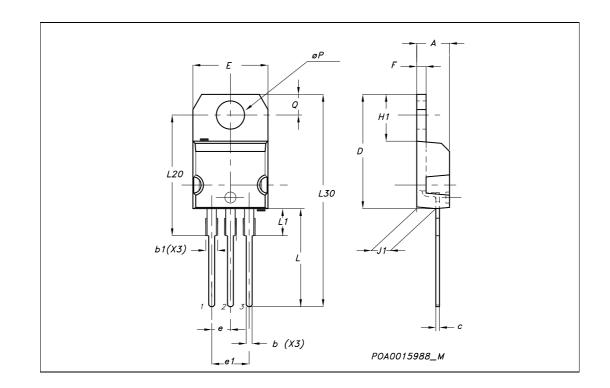
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DIM.		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øР	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116





5 Revision history

Date	Revision	Changes
21-Jun-2004	2	Preliminary datasheet
22-Aug-2005	3	Complete document with curves
21-Jan-2006	4	New ECOPAK label
02-Oct-2006	5	New template, no content change



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